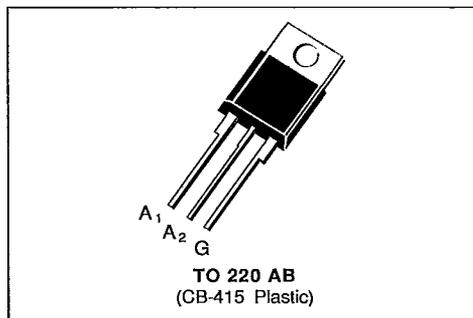


- $I_{TRMS} = 6\text{ A}$ at $T_c = 80\text{ }^\circ\text{C}$.
- $V_{DRM} : 200\text{ V}$ to 800 V .
- $I_{GT} = 5\text{ mA}$ (QI-II-III).
- $(di/dt)_c = 2.7\text{ A/ms}$ @ $(dv/dt)_c = 20\text{ V}/\mu\text{s}$.
- SUITED FOR LOW POWER TRIGGER CIRCUITS (INTEGRATED CIRCUITS AND MICROPROCESSORS).
- GLASS PASSIVATED CHIP.
- HIGH EFFICIENCY SWITCHING.
- AVAILABLE IN INSULATED VERSION → BTA SERIES (INSULATING VOLTAGE : 2500 V_{RMS}) OR IN UNINSULATED VERSION → BTB SERIES.
- UL RECOGNIZED FOR BTA SERIES (E81734).

DESCRIPTION

New range suited for applications such as phase control and static switching on inductive or resistive load.

**ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter		Value	Unit
I_{TRMS}	RMS on-state current (360° conduction angle)	$T_c = 80\text{ }^\circ\text{C}$	6	A
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = $25\text{ }^\circ\text{C}$)	$t = 8.3\text{ ms}$	95	A
		$t = 10\text{ ms}$	85	
$I^2 t$	$I^2 t$ value	$t = 10\text{ ms}$	36	$\text{A}^2\text{ s}$
di/dt	Critical rate of rise of on-state current (1)	Repetitive $F = 50\text{ Hz}$	20	A/ μs
		Non Repetitive	100	
T_{stg} T_j	Storage and operating junction temperature range		- 40, + 150 - 40, + 110	$^\circ\text{C}$ $^\circ\text{C}$

Symbol	Parameter	BTA/BTB 06-					Unit
		200 TW	400 TW	600 TW	700 TW	800 TW	
V_{DRM}	Repetitive peak off-state voltage (2)	± 200	± 400	± 600	± 700	± 800	V

(1) Gate supply : $I_G = 50\text{ mA}$ - $di_G/dt = 1\text{ A}/\mu\text{s}$

(2) $T_j = 110\text{ }^\circ\text{C}$.

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THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	60	°C/W
$R_{th(j-c)}$ DC	Junction to case for DC	4.8	°C/W
$R_{th(j-c)}$ AC	Junction to case for 360 ° conduction angle (F = 50 Hz)	3.6	°C/W

GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40\text{ W}$ (t = 10 μs) $P_{G(AV)} = 1\text{ W}$ $I_{GM} = 4\text{ A}$ (t = 10 μs) $V_{GM} = 16\text{ V}$ (t = 10 μs).

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions	Quadrants	Min.	Typ.	Max.	Unit
I_{GT}	$T_J = 25\text{ °C}$ $V_D = 12\text{ V}$ $R_L = 33\text{ }\Omega$ Pulse duration > 20 μs	I-II-III			5	mA
V_{GT}	$T_J = 25\text{ °C}$ $V_D = 12\text{ V}$ $R_L = 33\text{ }\Omega$ Pulse duration > 20 μs	I-II-III			1.5	V
V_{GD}	$T_J = 110\text{ °C}$ $V_D = V_{DRM}$ $R_L = 3.3\text{ k}\Omega$ Pulse duration > 20 μs	I-II-III	0.2			V
I_H^*	$T_J = 25\text{ °C}$ $I_T = 100\text{ mA}$ Gate open $R_L = 140\text{ }\Omega$				15	mA
I_L	$T_J = 25\text{ °C}$ $V_D = 12\text{ V}$ $R_L = 33\text{ }\Omega$ Pulse duration > 20 μs	I-III		15		mA
		II		30		
V_{TM}^*	$T_J = 25\text{ °C}$ $I_{TM} = 8.5\text{ A}$ $t_p = 10\text{ ms}$				1.75	V
I_{DRM}^*	$T_J = 25\text{ °C}$ $T_J = 110\text{ °C}$ V_{DRM} rated Gate open				10	μA
					500	
dv/dt^*	$T_J = 110\text{ °C}$ Gate open Linear slope up to 0.67 V_{DRM}		20			V/ μs
$(di/dt)_c^*$	$T_J = 110\text{ °C}$ $(dv/dt)_c = 0.1\text{ V}/\mu\text{s}$ $T_J = 110\text{ °C}$ $(dv/dt)_c = 20\text{ V}/\mu\text{s}$		2.7	4		A/ms
			1.3	2.7		
t_{gt}	$T_J = 25\text{ °C}$ $di_G/dt = 1\text{ A}/\mu\text{s}$ $I_G = 25\text{ mA}$ $I_T = 8.5\text{ A}$ $V_D = V_{DRM}$	I-II-III		2		μs

* For either polarity of electrode A₂ voltage with reference to electrode A₁.

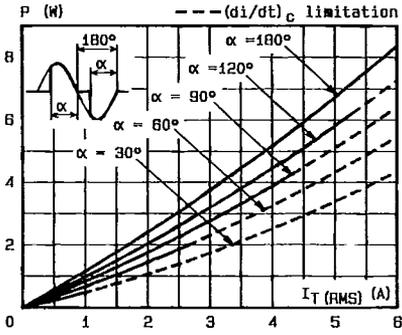


Fig.1 - Maximum mean power dissipation versus RMS on-state current ($F = 60 \text{ Hz}$).

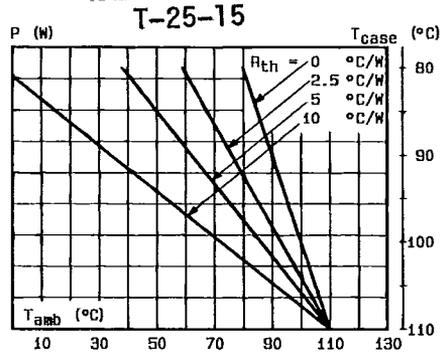


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

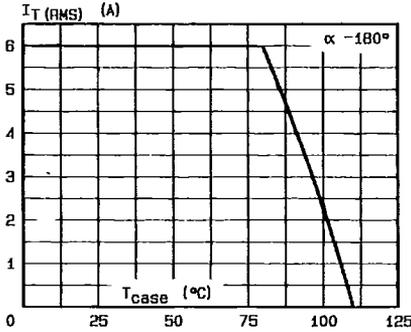


Fig.3 - RMS on-state current versus case temperature.

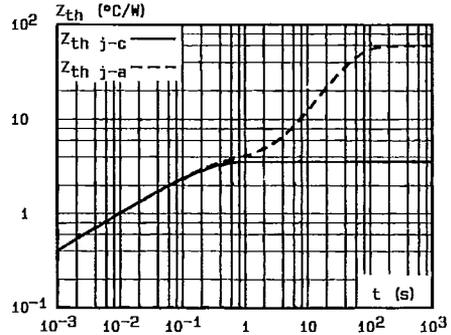


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

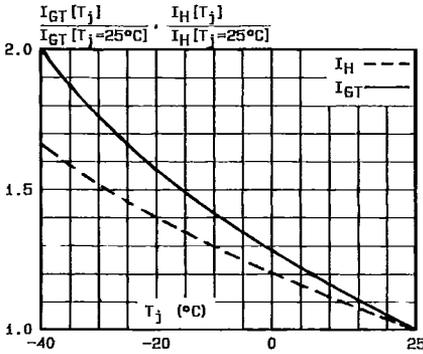


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

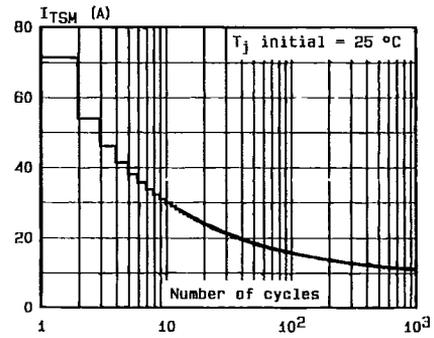


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.

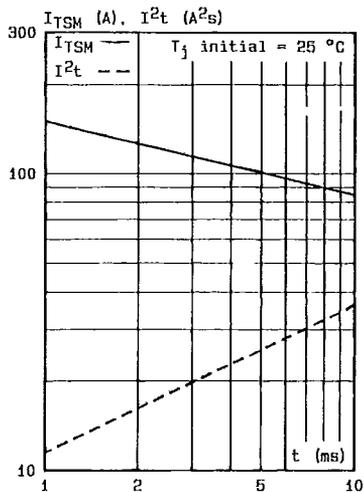


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \leq 10$ ms, and corresponding value of I^2t .

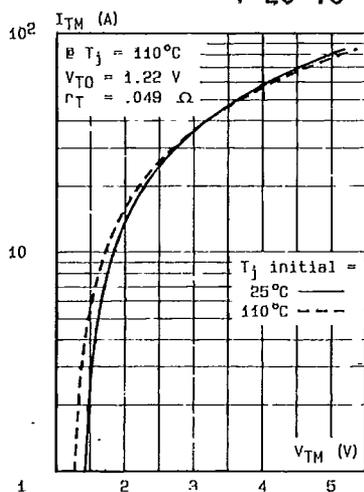


Fig.8 - On-state characteristics (maximum values).

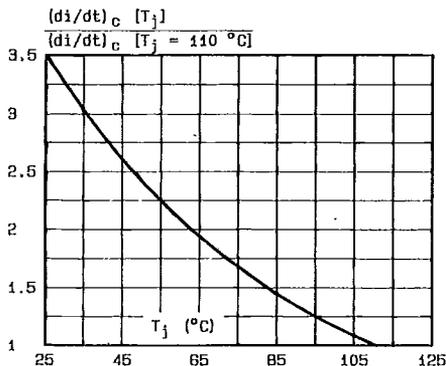


Fig.9 - Relative variation of $(di/dt)_c$ versus junction temperature.

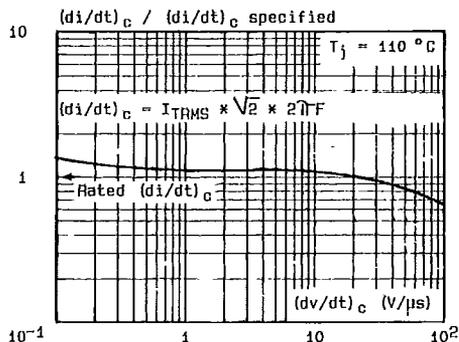


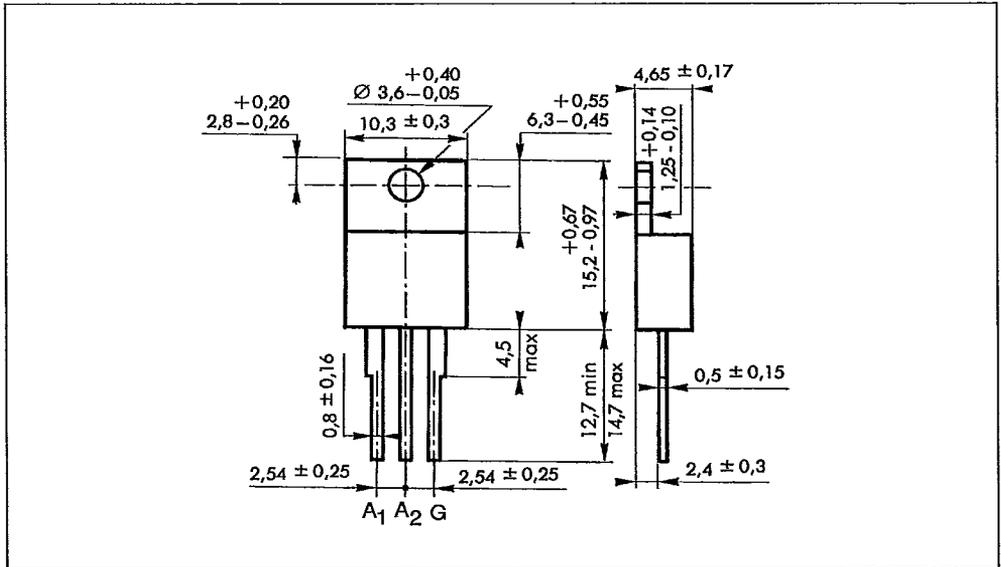
Fig.10 - Relative variation of $(di/dt)_c$ versus $(dv/dt)_c$ (inductive load) (typical values).

S G S-THOMSON

PACKAGE MECHANICAL DATA

T-25-15

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)

Marking : type number

Weight : 2 g